



LMH6702 1.7-GHz Ultra-Low Distortion Wideband Op Amp

1 Features

$V_S = \pm 5\text{ V}$, $T_A = 25^\circ\text{C}$, $A_V = 2\text{ V/V}$, $R_L = 100\ \Omega$,
 $V_{OUT} = 2\text{ V}_{PP}$, Typical Unless Noted:

- 2nd and 3rd Harmonics (5 MHz, SOT-23) $-100/-96\text{ dBc}$
- -3 dB Bandwidth ($V_{OUT} = 0.5\text{ V}_{PP}$) 1.7 GHz
- Low Noise $1.83\text{ nV}/\sqrt{\text{Hz}}$
- Fast Settling to 0.1% 13.4 ns
- Fast Slew Rate $3100\text{ V}/\mu\text{s}$
- Supply Current 12.5 mA
- Output Current 80 mA
- Low Intermodulation Distortion (75 MHz) -67 dBc
- Improved Replacement for CLC409 and CLC449

2 Applications

- Flash A-D Driver
- D-A Transimpedance Buffer
- Wide Dynamic Range IF Amp
- Radar and Communication Receivers
- Line Driver
- High Resolution Video

3 Description

The LMH6702 is a very wideband, DC-coupled monolithic operational amplifier designed specifically for wide dynamic range systems requiring exceptional signal fidelity. Benefitting from current feedback architecture, the LMH6702 offers unity gain stability at exceptional speed without need for external compensation.

With its 720-MHz bandwidth ($A_V = 2\text{ V/V}$, $V_O = 2\text{ V}_{PP}$), 10-bit distortion levels through 60-MHz ($R_L = 100\ \Omega$), $1.83\text{ nV}/\sqrt{\text{Hz}}$ input referred noise and 12.5-mA supply current, the LMH6702 is the ideal driver or buffer for high-speed flash A-D and D-A converters.

Wide dynamic range systems such as radar and communication receivers that require a wideband amplifier offering exceptional signal purity will find the low input referred noise and low harmonic and intermodulation distortion of the LMH6702 an attractive high speed solution.

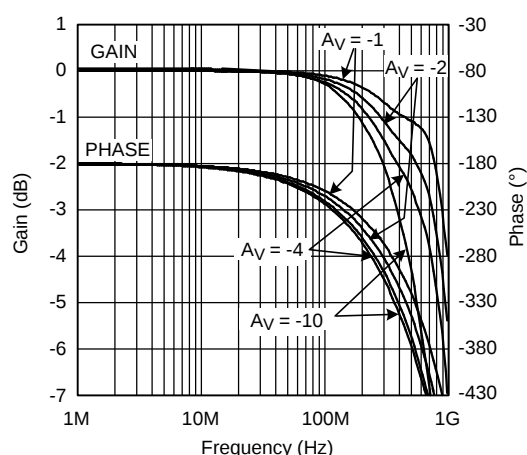
The LMH6702 is constructed using VIP10™ complimentary bipolar process and proven current feedback architecture. The LMH6702 is available in SOIC and SOT-23 packages.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)
LMH6702	SOIC (8)	4.90 mm × 3.91 mm
	SOT-23 (5)	2.90 mm × 1.60 mm

(1) For all available packages, see the orderable addendum at the end of the datasheet.

Inverting Frequency Response



Harmonic Distortion vs Load and Frequency

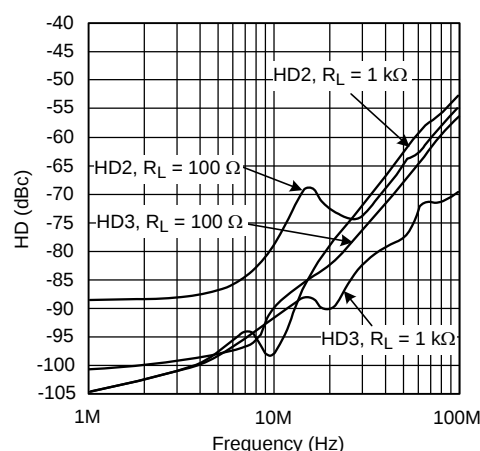


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4 Revision History

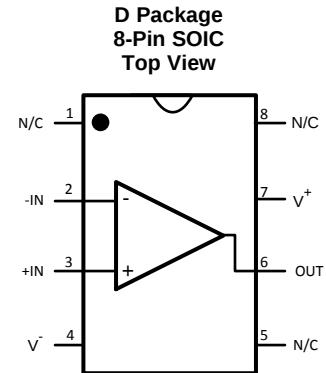
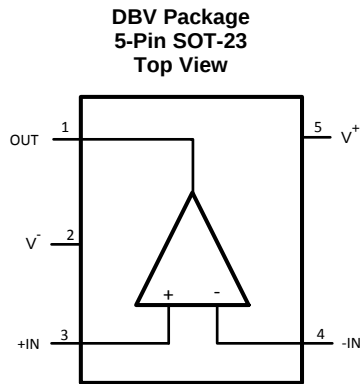
NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision G (October 2014) to Revision H	Page
• Updated <i>Thermal Information</i>	4
• Changed non-inverting input bias (with no test conditions) current maximum value from $\pm 15 \mu\text{A}$ to $-15 \mu\text{A}$	6
• Changed non-inverting input bias ($-40 \leq T_J \leq 85$) current maximum value from $\pm 21 \mu\text{A}$ to $-21 \mu\text{A}$	6
• Added <i>Community Resources</i> section	17

Changes from Revision F (March 2013) to Revision G	Page
• Added, updated, or renamed the following sections: <i>Device Information</i> ; <i>Specifications</i> ; <i>Application and Implementation</i> ; <i>Power Supply Recommendations</i> ; <i>Layout</i> ; <i>Device and Documentation Support</i> ; <i>Mechanical, Packaging, and Ordering Information</i>	1
• Changed $\pm 5 \text{ V}$ to $\pm 4 \text{ V}$ in <i>Recommended Operating Conditions</i>	4

Changes from Revision E (March 2013) to Revision F	Page
• Changed layout of National Data Sheet to TI format	1

5 Pin Configuration and Functions



NC: No internal connection

Pin Functions

NAME	PIN NUMBER		I/O	DESCRIPTION
	D	DBV		
-IN	2	4	I	Inverting input voltage
+IN	3	3	I	Non-inverting input voltage
N/C	1, 5, 8	–	–	No connection
OUT	6	1	O	Output
V-	4	2	I	Negative supply
V+	7	5	I	Positive supply

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) ⁽¹⁾⁽²⁾

	MIN	MAX	UNIT
V_S		±6.75	V
I_{OUT}		See ⁽³⁾	
Common mode input voltage		V^- to V^+	V
Maximum junction temperature		150	°C
Storage temperature	–65	150	°C
Soldering information	Infrared or convection (20 s)	235	°C
	Wave soldering (10 s)	260	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) If Military/Aerospace specified devices are required, please contact the TI Sales Office/ Distributors for availability and specifications.
- (3) The maximum output current (I_{OUT}) is determined by device power dissipation limitations.

6.2 ESD Ratings

	VALUE	UNIT
$V_{(ESD)}$ Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000
	Machine Model (MM), per JEDEC specification JESD22-C101, all pins ⁽²⁾	±200

- (1) Human body model: 1.5 k Ω in series with 100 pF. JEDEC document JEP155 states that 2000-V HBM allows safe manufacturing with a standard ESD control process. Manufacturing with less than 2000-V HBM is possible with the necessary precautions. Pins listed as ±2000 V may actually have higher performance.
- (2) Machine model: 0 Ω in series with 200 pF. JEDEC document JEP157 states that 200-V MM allows safe manufacturing with a standard ESD control process. Manufacturing with less than 200-V MM is possible with the necessary precautions. Pins listed as ±200 V may actually have higher performance.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted) ⁽¹⁾

	MIN	MAX	UNIT
Operating temperature	–40	85	°C
Nominal supply voltage	±4	±6	V

- (1) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is intended to be functional, but specific performance is not ensured. For ensured specifications, see the Electrical Characteristics tables.

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾		LMH6702		UNIT
		DBV (SOT-23)	D (SOIC)	
		5 PINS	8 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	182	133	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	139	79	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	40	73	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	28	28	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	40	73	°C/W

- (1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report (SPRA953).

6.5 Electrical Characteristics

at $A_V = 2$, $V_S = \pm 5\text{ V}$, $R_L = 100\ \Omega$, $R_F = 237\ \Omega$ (unless otherwise noted)⁽¹⁾

PARAMETER		TEST CONDITIONS	MIN ⁽²⁾	TYP ⁽³⁾	MAX ⁽²⁾	UNIT
FREQUENCY DOMAIN PERFORMANCE						
SSBW _{SM}	-3-dB Bandwidth	V _{OUT} = 0.5 V _{PP}		1700		MHz
SSBW _{LG}		V _{OUT} = 2 V _{PP}		720		
LSBW _{LG}		V _{OUT} = 4 V _{PP}		480		
SSBW _{HG}		V _{OUT} = 2 V _{PP} , A _V = +10		140		
GF _{0.1dB}	0.1-dB gain flatness	V _{OUT} = 2 V _{PP}		120		MHz
LPD	Linear phase deviation	DC to 100 MHz		0.09		deg
DG	Differential gain	R _L =150 Ω, 3.58 MHz		0.024%		
		R _L =150 Ω, 4.43 MHz		0.021%		
DP	Differential phase	R _L = 150 Ω, 3.58 MHz		0.004		deg
		R _L = 150 Ω, 4.43 MHz		0.007		
TIME DOMAIN RESPONSE						
t _R	Rise time	2-V Step, TRS		0.87		ns
		2-V Step, TRL		0.77		
t _F	Fall time	6-V Step, TRS		1.70		ns
		6-V Step, TRL		1.70		
OS	Overshoot	2-V Step		0%		
SR	Slew rate	6 V _{PP} , 40% to 60% ⁽⁴⁾		3100		V/μs
T _s	Settling time to 0.1%	2-V Step		13.4		ns
DISTORTION AND NOISE RESPONSE						
HD2L	2 nd Harmonic distortion	2 V _{PP} , 5 MHz ⁽⁵⁾ (SOT-23)		-100		dBc
		2 V _{PP} , 5 MHz ⁽⁵⁾ (SOIC)		-87		
HD2		2V _{PP} , 20 MHz ⁽⁵⁾ (SOT-23)		-79		dBc
		2V _{PP} , 20 MHz ⁽⁵⁾ (SOIC)		-72		
HD2H		2V _{PP} , 60 MHz ⁽⁵⁾ (SOT-23)		-63		dBc
		2V _{PP} , 60 MHz ⁽⁵⁾ (SOIC)		-64		
HD3L	3 rd Harmonic distortion	2V _{PP} , 5 MHz ⁽⁵⁾ (SOT-23)		-96		dBc
		2V _{PP} , 5 MHz ⁽⁵⁾ (SOIC)		-98		
HD3		2V _{PP} , 20 MHz ⁽⁵⁾ (SOT-23)		-88		dBc
		2V _{PP} , 20 MHz ⁽⁵⁾ (SOIC)		-82		
HD3H		2V _{PP} , 60 MHz ⁽⁵⁾ (SOT-23)		-70		dBc
		2V _{PP} , 60 MHz ⁽⁵⁾ (SOIC)		-65		
OIM3	IMD	75 MHz, P _O = 10dBm/ tone		-67		dBc
V _N	Input referred voltage noise	>1 MHz		1.83		nV/√Hz
I _N	Input referred inverting noise current	>1 MHz		18.5		pA/√Hz
I _{NN}	Input referred non-inverting noise current	>1 MHz		3.0		pA/√Hz
SNF	Total input noise floor	>1 MHz		-158		dBm _{1Hz}
INV	Total integrated input noise	1 MHz to 150 MHz		35		μV

- (1) Electrical Table values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device such that $T_J = T_A$. No guarantee of parametric performance is indicated in the electrical tables under conditions of internal self-heating where $T_J > T_A$. Min/Max ratings are based on production testing unless otherwise specified.
- (2) All limits are ensured by testing or statistical analysis.
- (3) Typical numbers are the most likely parametric norm.
- (4) Slew Rate is the average of the rising and falling edges.
- (5) Harmonic distortion is strongly influenced by package type (SOT-23 or SOIC). See Application Note section under [Harmonic Distortion](#) for more information.

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Electrical Characteristics (continued)

 at $A_V = 2$, $V_S = \pm 5\text{ V}$, $R_L = 100\ \Omega$, $R_F = 237\ \Omega$ (unless otherwise noted)⁽¹⁾

PARAMETER		TEST CONDITIONS		MIN ⁽²⁾	TYP ⁽³⁾	MAX ⁽²⁾	UNIT
STATIC, DC PERFORMANCE							
V _{IO}	Input offset voltage			±1.0	±4.5		mV
			-40 ≤ T _J ≤ 85		±6.0		
DV _{IO}	Input offset voltage average drift	See ⁽⁶⁾		-13			μV/°C
I _{BN}	Input bias current	Non-Inverting ⁽⁷⁾		-6	-15		μA
			-40 ≤ T _J ≤ 85		-21		
DI _{BN}	Input bias current average drift	Non-Inverting ⁽⁶⁾		+40			nA/°C
I _{BI}	Input bias current	Inverting ⁽⁷⁾		-8	±30		μA
			-40 ≤ T _J ≤ 85		±34		
DI _{BI}	Input bias current average drift	Inverting ⁽⁶⁾		-10			nA/°C
PSRR	Power supply rejection ratio	DC		47	52		dB
			-40 ≤ T _J ≤ 85	45			
CMRR	Common mode rejection ration	DC		45	48		dB
			-40 ≤ T _J ≤ 85	44			
I _{CC}	Supply current	R _L = ∞		11.0	12.5	16.1	mA
			-40 ≤ T _J ≤ 85	10.0		17.5	
MISCELLANEOUS PERFORMANCE							
R _{IN}	Input resistance	Non-Inverting		1.4			MΩ
C _{IN}	Input capacitance	Non-Inverting		1.6			pF
R _{OUT}	Output resistance	Closed Loop		30			mΩ
V _{OL}	Output voltage range	R _L = 100 Ω		±3.3	±3.5		V
			-40 ≤ T _J ≤ 85	±3.2			
CMIR	Input voltage range	Common Mode		±1.9	±2.2		V
I _O	Output current			50	80		mA

(6) Drift determined by dividing the change in parameter at temperature extremes by the total temperature change.

(7) Negative input current implies current flowing out of the device.

6.6 Typical Characteristics

$T_A = 25^\circ\text{C}$, $V_S = \pm 5\text{ V}$, $R_L = 100\ \Omega$, $R_F = 237\ \Omega$ (unless otherwise noted)

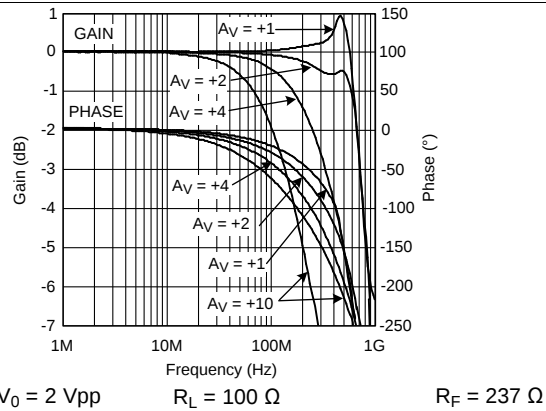


Figure 1. Non-Inverting Frequency Response

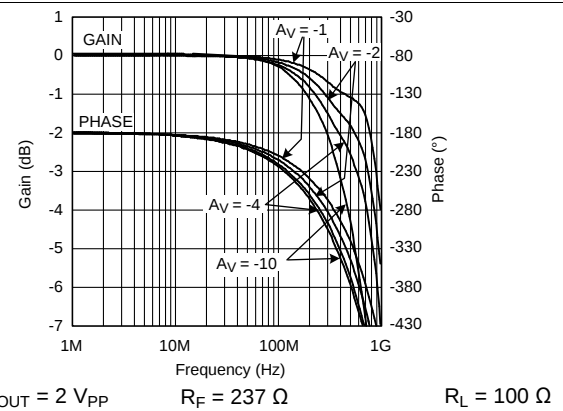


Figure 2. Inverting Frequency Response

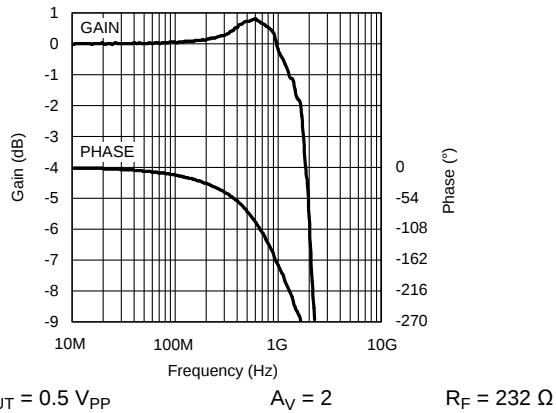


Figure 3. Small Signal Bandwidth

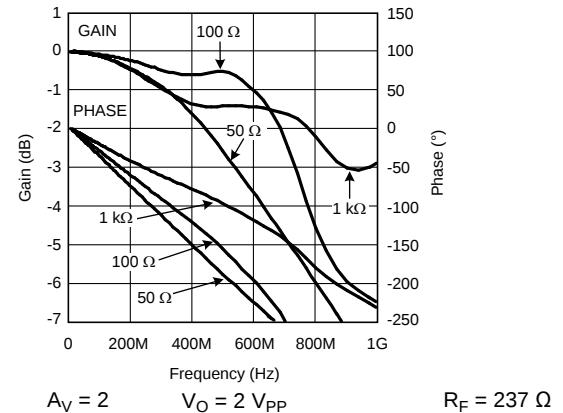


Figure 4. Frequency Response for Various R_L s, $A_V = 2$

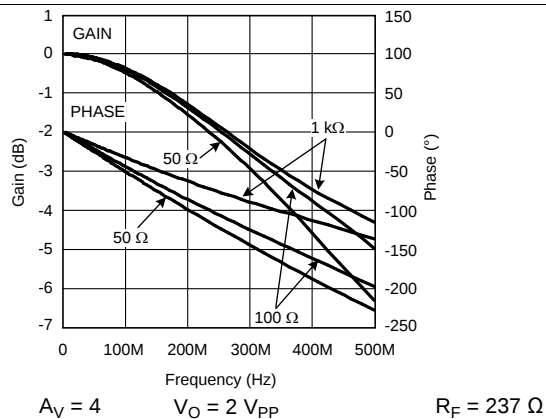


Figure 5. Frequency Response for Various R_L s, $A_V = 4$

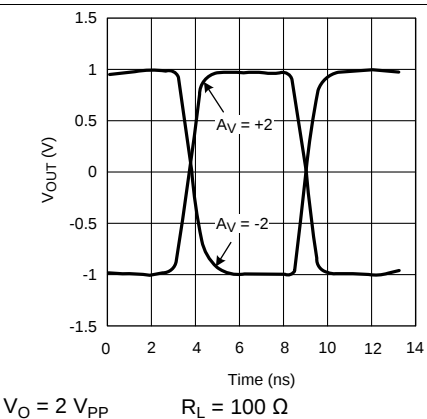
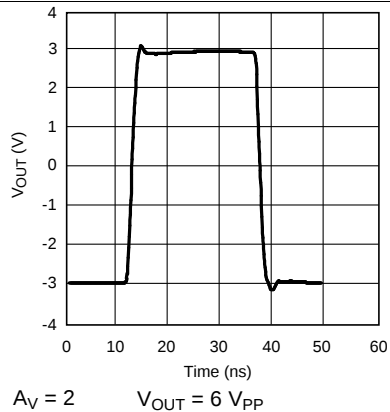
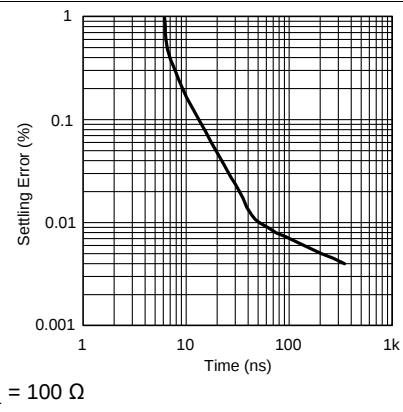
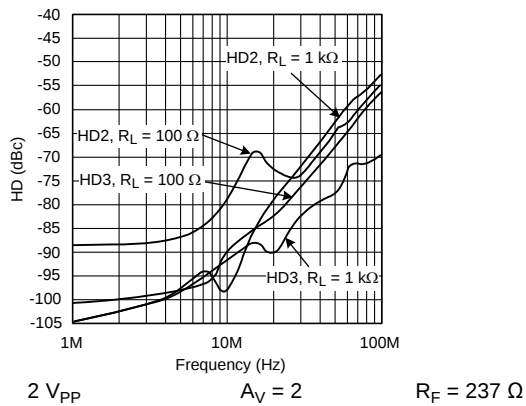
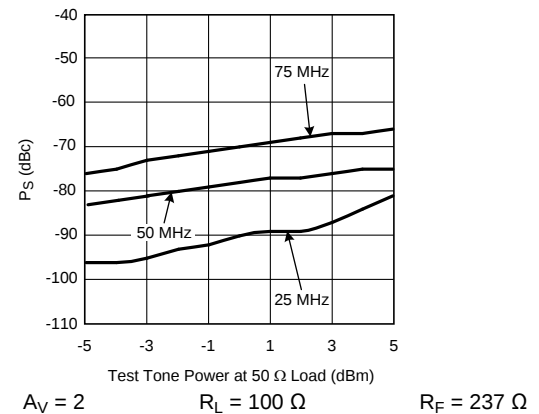
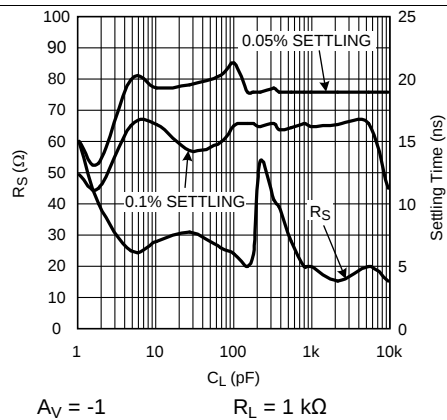
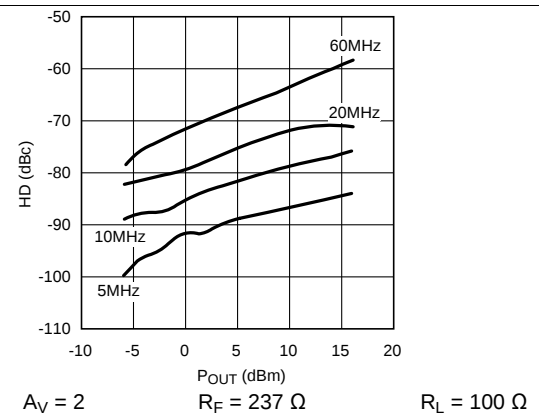


Figure 6. Step Response, 2 Vpp

Typical Characteristics (continued)

 $T_A = 25^\circ\text{C}$, $V_S = \pm 5\text{ V}$, $R_L = 100\ \Omega$, $R_F = 237\ \Omega$ (unless otherwise noted)

Figure 7. Step Response, 6 V_{PP}

Figure 8. Percent Settling vs Time

Figure 9. Harmonic Distortion vs Load and Frequency (SOIC Package)

Figure 10. 2 Tone 3rd Order Spurious Level (SOIC Package)

Figure 11. R_S and Settling Time vs C_L

Figure 12. HD2 vs Output Power (Across 100 Ω) (SOIC Package)

Typical Characteristics (continued)

$T_A = 25^\circ\text{C}$, $V_S = \pm 5\text{ V}$, $R_L = 100\ \Omega$, $R_F = 237\ \Omega$ (unless otherwise noted)

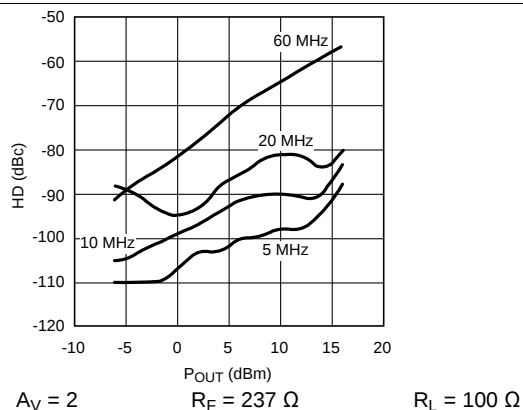


Figure 13. HD3 vs Output Power (Across 100 Ω) (SOIC Package)

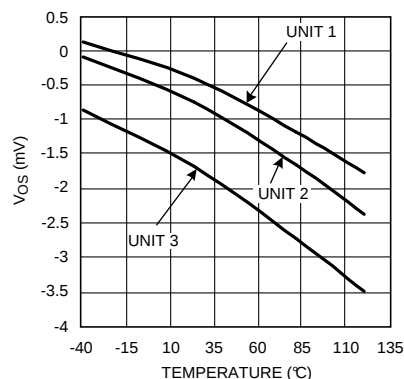


Figure 14. Input Offset for 3 Representative Units

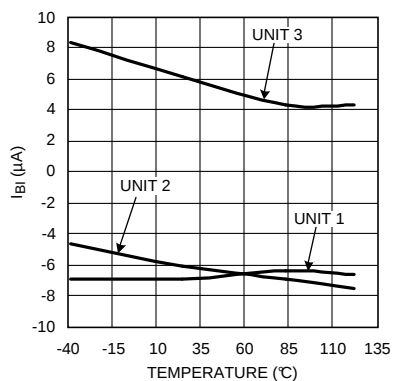


Figure 15. Inverting Input Bias for 3 Representative Units

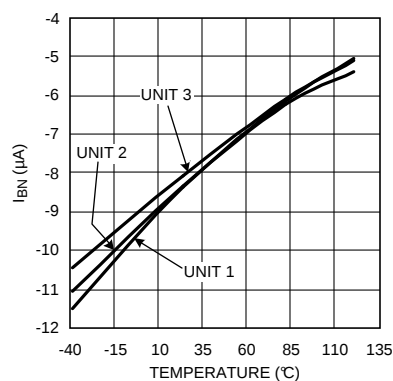


Figure 16. Non-Inverting Input Bias for 3 Representative Units

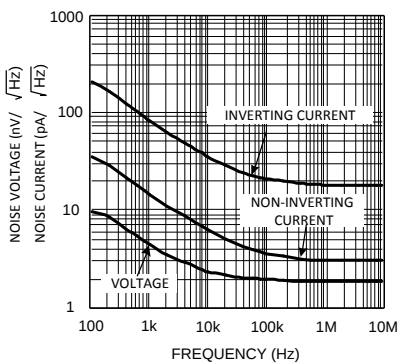


Figure 17. Noise

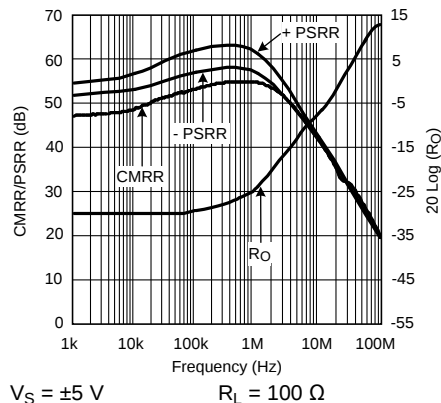


Figure 18. CMRR, PSRR, R_{OUT}

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Typical Characteristics (continued)

$T_A = 25^\circ\text{C}$, $V_S = \pm 5\text{ V}$, $R_L = 100\ \Omega$, $R_F = 237\ \Omega$ (unless otherwise noted)

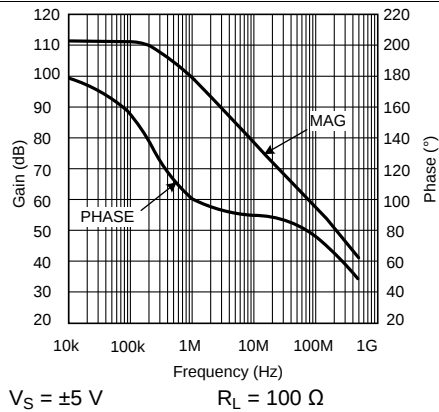


Figure 19. Transimpedance

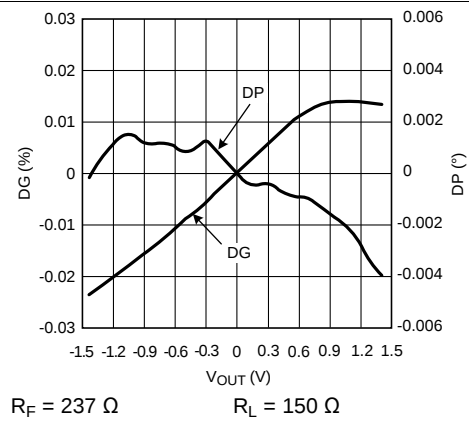


Figure 20. DG/DP (NTSC)

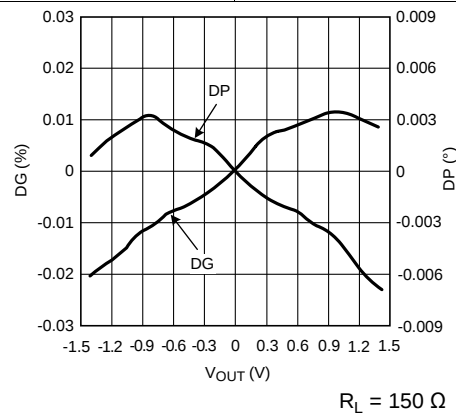


Figure 21. DG/DP (PAL)

7 Detailed Description

7.1 Overview

The LMH6702 has been optimized for exceptionally low harmonic distortion while driving very demanding resistive or capacitive loads. Generally, when used as the input amplifier to very high speed flash ADCs, the distortions introduced by the converter will dominate over the low LMH6702 distortions shown in [Typical Characteristics](#).

7.2 Feature Description

7.2.1 Harmonic Distortion

The capacitor C_{SS} , shown across the supplies in [Figure 24](#) and [Figure 25](#), is critical to achieving the lowest 2nd harmonic distortion. For absolute minimum distortion levels, it is also advisable to keep the supply decoupling currents (ground connections to C_{POS} , and C_{NEG} in [Figure 24](#) and [Figure 25](#)) separate from the ground connections to sensitive input circuitry (such as R_G , R_T , and R_{IN} ground connections). Splitting the ground plane in this fashion and separately routing the high frequency current spikes on the decoupling caps back to the power supply (similar to *Star Connection* layout technique) ensures minimum coupling back to the input circuitry and results in best harmonic distortion response (especially 2nd order distortion).

If this layout technique has not been observed on a particular application board, designer may actually find that supply decoupling caps could adversely affect HD2 performance by increasing the coupling phenomenon already mentioned. [Figure 22](#) shows actual HD2 data on a board where the ground plane is *shared* between the supply decoupling capacitors and the rest of the circuit. Once these capacitors are removed, the HD2 distortion levels reduce significantly, especially between 10 MHz to 20 MHz, as shown in [Figure 22](#):

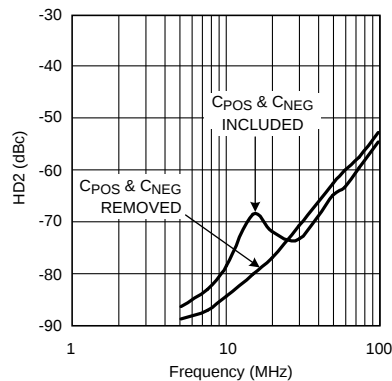


Figure 22. Decoupling Current Adverse Effect on a Board with Shared Ground Plane

At these extremely low distortion levels, the high frequency behavior of decoupling capacitors themselves could be significant. In general, lower value decoupling caps tend to have higher resonance frequencies making them more effective for higher frequency regions. A particular application board which has been laid out correctly with ground returns *split* to minimize coupling, would benefit the most by having low value and higher value capacitors paralleled to take advantage of the effective bandwidth of each and extend low distortion frequency range.

Another important variable in getting the highest fidelity signal from the LMH6702 is the package itself. As already noted, coupling between high frequency current transients on supply lines and the device input can lead to excess harmonic distortion. An important source of this coupling is in fact through the device bonding wires. A smaller package, in general, will have shorter bonding wires and therefore lower coupling. This is true in the case of the SOT-23 compared to the SOIC package where a marked improvement in HD can be measured in the SOT-23 package. [Figure 23](#) shows the HD comparing SOT-23 to SOIC package:

Feature Description (continued)

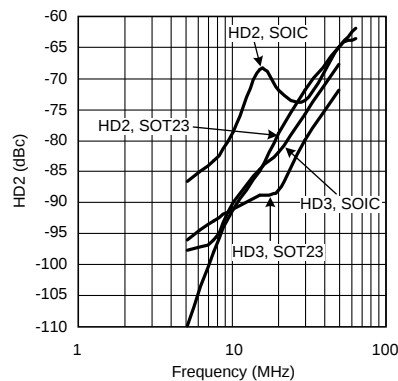


Figure 23. SOIC and SOT-23 Packages Distortion Terms Compared

The LMH6702 data sheet shows both SOT-23 and SOIC data in [Electrical Characteristics](#) to aid in selecting the right package. [Typical Characteristics](#) shows SOIC package plots only.

7.3 Device Functional Modes

7.3.1 2-Tone 3rd Order Intermodulation

[Figure 10](#) shows a relatively constant difference between the test power level and the spurious level with the difference depending on frequency. The LMH6702 does not show an intercept type performance, (where the relative spurious levels change at a 2X rate versus the test tone powers), due to an internal full power bandwidth enhancement circuit that boosts the performance as the output swing increases while dissipating negligible quiescent power under low output power conditions. This feature enhances the distortion performance and full power bandwidth to match that of much higher quiescent supply current parts.

7.3.2 DC Accuracy and Noise

The example in [Equation 1](#) shows the output offset computation equation for the non-inverting configuration using the typical bias current and offset specifications for $A_V = 2$:

Output Offset:

$$V_O = (\pm I_{BN} \cdot R_{IN} \pm V_{IO}) (1 + R_F/R_G) \pm I_{BI} \cdot R_F$$

where

- R_{IN} is the equivalent input impedance on the non-inverting input. (1)

Example computation for $A_V = +2$, $R_F = 237\Omega$, $R_{IN} = 25\Omega$:

$$V_O = (\pm 6 \mu A \times 25 \Omega \pm 1 mV) (1 + 237/237) \pm 8 \mu A \times 237 = \pm 4.20 mV \quad (2)$$

A good design, however, should include a worst case calculation using min/max numbers in the data sheet tables, in order to ensure *worst case* operation.

Further improvement in the output offset voltage and drift is possible using the composite amplifiers described in Application Note OA--07, *Current Feedback Op Amp Applications Circuit Guide* ([SNOA365](#)). The two input bias currents are physically unrelated in both magnitude and polarity for the current feedback topology. It is not possible, therefore, to cancel their effects by matching the source impedance for the two inputs (as is commonly done for matched input bias current devices).

The total output noise is computed in a similar fashion to the output offset voltage. Using the input noise voltage and the two input noise currents, the output noise is developed through the same gain equations for each term but combined as the square root of the sum of squared contributing elements. See Application Note OA-12, *Noise Analysis for Comlinear Amplifiers* ([SNOA375](#)) for a full discussion of noise calculations for current feedback amplifiers.

8 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

The LMH6702 achieves its excellent pulse and distortion performance by using the current feedback topology. The loop gain for a current feedback op amp, and hence the frequency response, is predominantly set by the feedback resistor value. The LMH6702 is optimized for use with a 237-Ω feedback resistor. Using lower values can lead to excessive ringing in the pulse response while a higher value will limit the bandwidth.

8.2 Typical Application

8.2.1 Feedback Resistor

The LMH6702 achieves its excellent pulse and distortion performance by using the current feedback topology. The loop gain for a current feedback op amp, and hence the frequency response, is predominantly set by the feedback resistor value. The LMH6702 is optimized for use with a 237-Ω feedback resistor. Using lower values can lead to excessive ringing in the pulse response while a higher value will limit the bandwidth.

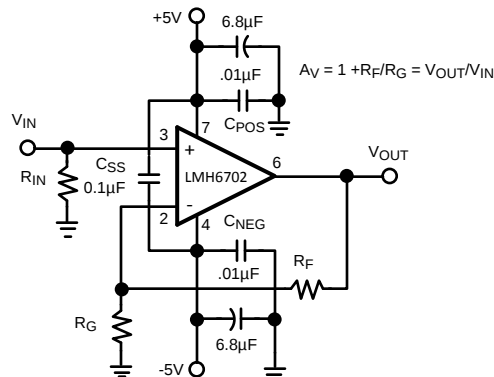


Figure 24. Recommended Non-Inverting Gain Circuit

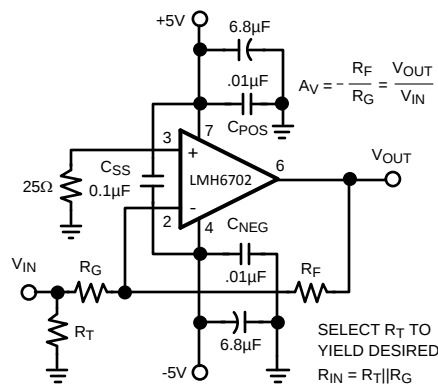


Figure 25. Recommended Inverting Gain Circuit

Typical Application (continued)

8.2.2 Design Requirements

The exceptional performance and uniquely targeted superior technical specifications of the LMH6702 make it a natural choice for high speed data acquisition applications as a front end amplifier driving the input of a high performance ADC. Of these specifications, the following can be discussed in more detail:

1. A bandwidth of 1.7 GHz and relative insensitivity of bandwidth to closed loop gain (characteristic of Current Feedback architecture when compared to the traditional voltage feedback architecture) as shown in [Figure 1](#).
2. Ultra-low distortion approaching -87 dBc at the lower frequencies and exceptional noise performance (see [Figure 9](#) and [Figure 17](#)).
3. Fast settling in less than 20 ns (see [Figure 27](#)).

As the input of an ADC could be capacitive in nature and could also alternate in capacitance value during a typical acquisition cycle, the driver amplifier (LMH6702 in this case) should be designed so that it avoids instability, peaking, or other undesirable artifacts.

For Capacitive Load Drive, see [Figure 26](#), which shows a typical application using the LMH6702 to drive an ADC.

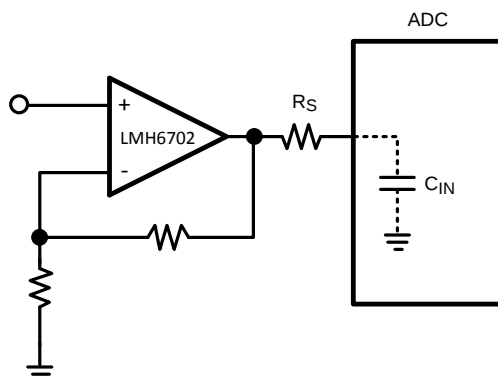


Figure 26. Input Amplifier to ADC

8.2.3 Detailed Design Procedure

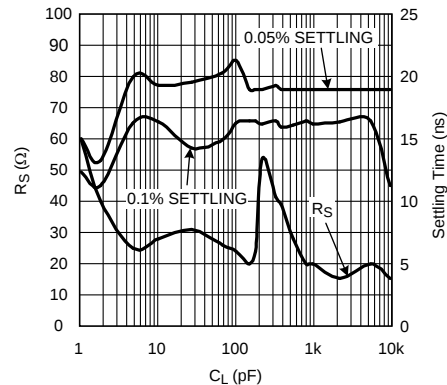
The series resistor, R_S , between the amplifier output and the ADC input is critical to achieving best system performance. This load capacitance, if applied directly to the output pin, can quickly lead to unacceptable levels of ringing in the pulse response. [Figure 27](#) in [Application Curve](#) (R_S and Settling Time vs C_{IN}) is an excellent starting point for selecting R_S . The value derived in that plot minimizes the step settling time into a fixed discrete capacitive load with the output driving a very light resistive load (1 k Ω). Sensitivity to capacitive loading is greatly reduced once the output is loaded more heavily. Therefore, for cases where the output is heavily loaded, R_S value may be reduced. The exact value may best be determined experimentally for these cases.

In applications where the LMH6702 is replacing the CLC409, care must be taken when the device is lightly loaded and some capacitance is present at the output. Due to the much higher frequency response of the LMH6702 compared to the CLC409, there could be increased susceptibility to low value output capacitance (parasitic or inherent to the board layout or otherwise being part of the output load). As already mentioned, this susceptibility is most noticeable when the LMH6702's resistive load is light. Parasitic capacitance can be minimized by careful lay out. Addition of an output snubber R-C network will also help by increasing the high frequency resistive loading.

Referring back to [Figure 26](#), it must be noted that several additional constraints should be considered in driving the capacitive input of an ADC. There is an option to increase R_S , band-limiting at the ADC input for either noise or Nyquist band-limiting purposes. However, increasing R_S too much can induce an unacceptably large input glitch due to switching transients coupling through from the *convert* signal. Also, C_{IN} is oftentimes a voltage dependent capacitance. This input impedance non-linearity will induce distortion terms that will increase as R_S is increased. Only slight adjustments up or down from the recommended R_S value should therefore be attempted in optimizing system performance.

Typical Application (continued)

8.2.4 Application Curve



$$A_V = -1$$

$$R_L = 1 \text{ k}\Omega$$

Figure 27. R_S and Settling Time vs C_L

9 Power Supply Recommendations

The LMH6702 can operate off a single supply or with dual supplies as long as the input CM voltage range (CMIR) has the required headroom to either supply rail. Supplies should be decoupled with low inductance, often ceramic, capacitors to ground less than 0.5 inches from the device pins. The use of ground plane is recommended, and as in most high speed devices, it is advisable to remove ground plane close to device sensitive pins such as the inputs.

10 Layout

10.1 Layout Guidelines

Generally, a good high frequency layout will keep power supply and ground traces away from the inverting input and output pins. Parasitic capacitances on these nodes to ground will cause frequency response peaking and possible circuit oscillations. See *Frequent Faux Pas in Applying Wideband Current Feedback Amplifiers*, Application Note OA-15 ([SNOA367](#)). Texas Instruments suggests the following evaluation boards as a guide for high frequency layout and as an aid in device testing and characterization. See [Table 1](#) for details.

The LMH6702 evaluation board(s) is a good example of high frequency layout techniques as a reference. General high-speed, signal-path layout suggestions include:

- Continuous ground planes are preferred for signal routing with matched impedance traces for longer runs. However, open up both ground and power planes around the capacitive sensitive input and output device pins as shown in [Figure 28](#). After the signal is sent into a resistor, parasitic capacitance becomes more of a bandlimiting issue and less of a stability issue.
- Use good, high-frequency decoupling capacitors (0.1 μF) on the ground plane at the device power pins as shown in [Figure 28](#). Higher value capacitors (2.2 μF) are required, but may be placed further from the device power pins and shared among devices. For best high-frequency decoupling, consider X2Y supply-decoupling capacitors that offer a much higher self-resonance frequency over standard capacitors.
- When using differential signal routing over any appreciable distance, use microstrip layout techniques with matched impedance traces.
- The input summing junction is very sensitive to parasitic capacitance. Connect any R_f and R_g elements into the summing junction with minimal trace length to the device pin side of the resistor, as shown in [Figure 29](#). The other side of these elements can have more trace length if needed to the source or to ground.

LMH6702

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10.2 Layout Example

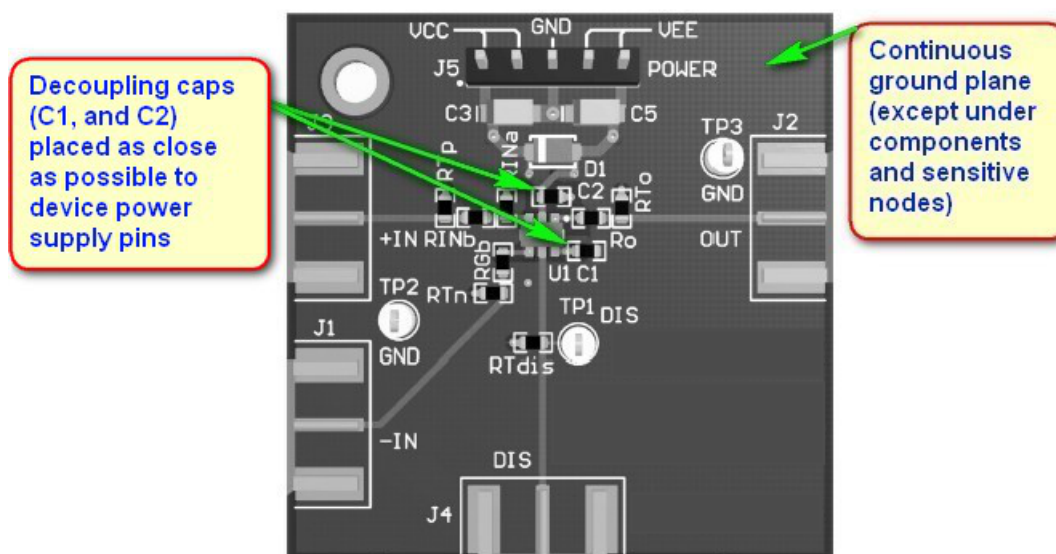


Figure 28. LMH6702 Evaluation Board Layer 1

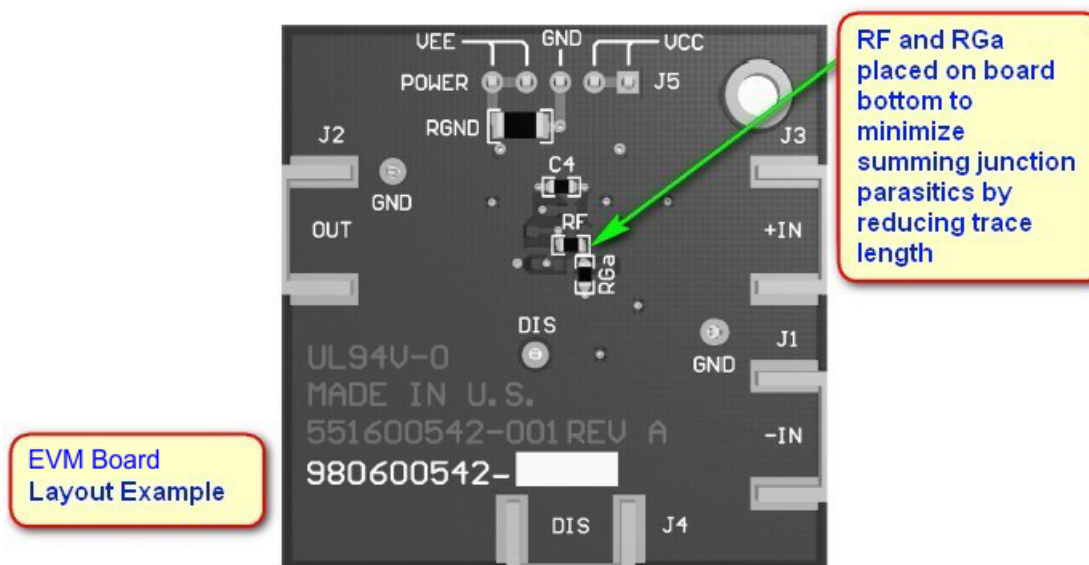


Figure 29. LMH6702 Evaluation Board Layer 2

Table 1. Evaluation Board Comparison

DEVICE	PACKAGE	EVALUATION BOARD PART NUMBER
LMH6702MF	SOT-23	LMH730216
LMH6702MA	SOIC	LMH730227

11 Device and Documentation Support

11.1 Documentation Support

11.1.1 Related Documentation

For related documentation, see the following:

- *Absolute Maximum Ratings for Soldering* ([SNOA549](#))
- *Current Feedback Op Amp Applications Circuit Guide*, Application Note OA--07 ([SNOA365](#))
- *Frequent Faux Pas in Applying Wideband Current Feedback Amplifiers*, Application Note OA-15 ([SNOA367](#))
- *Noise Analysis for Comlinear Amplifiers*, Application Note OA-12 ([SNOA375](#))
- *Semiconductor and IC Package Thermal Metrics* ([SPRA953](#))

11.2 Community Resources

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TI E2E™ Online Community *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At [e2e.ti.com](#), you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

11.3 Trademarks

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11.4 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

11.5 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
LMH6702MA	NRND	SOIC	D	8	95	TBD	Call TI	Call TI	-40 to 85	LMH67 02MA	
LMH6702MA/NOPB	ACTIVE	SOIC	D	8	95	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 85	LMH67 02MA	Samples
LMH6702MAX/NOPB	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 85	LMH67 02MA	Samples
LMH6702MF/NOPB	ACTIVE	SOT-23	DBV	5	1000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 85	A83A	Samples
LMH6702MFX/NOPB	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 85	A83A	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

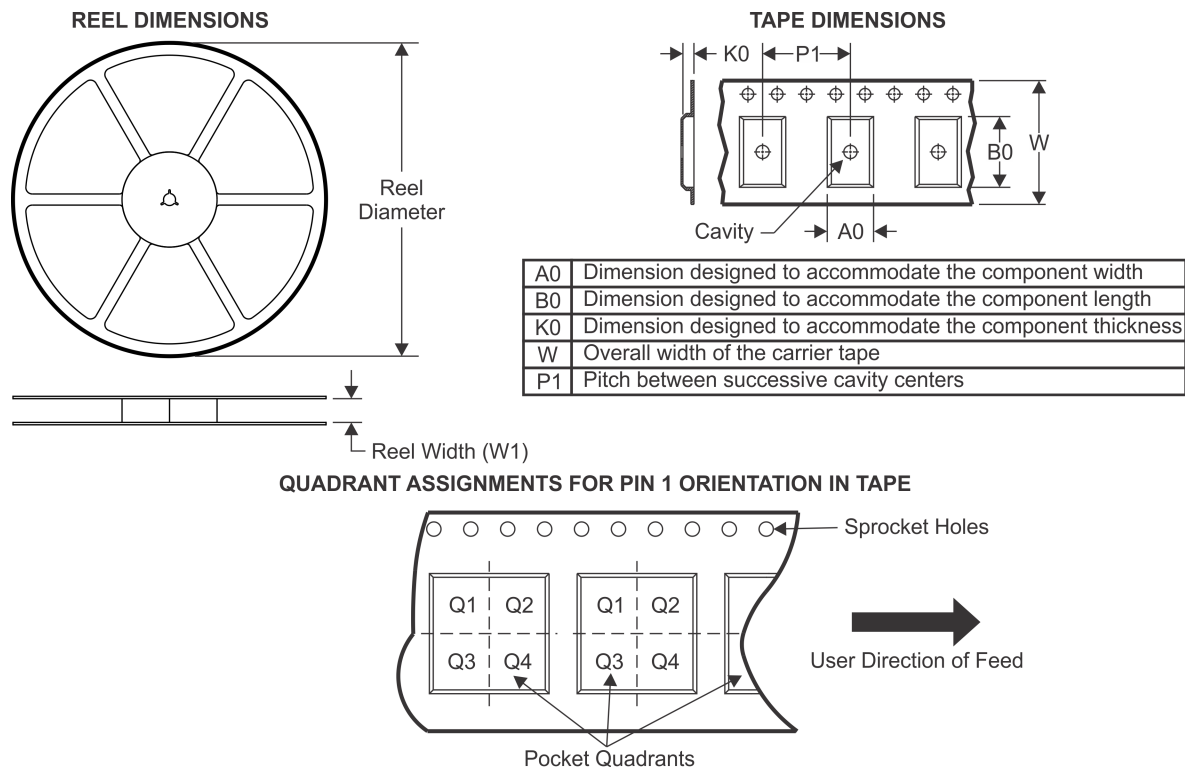
(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "-" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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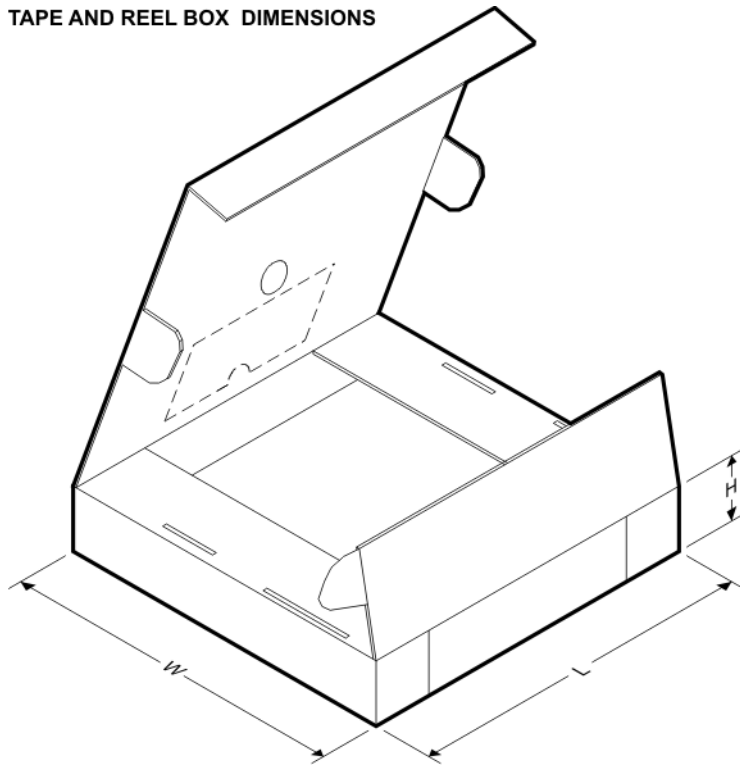
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TAPE AND REEL INFORMATION


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LMH6702MAX/NOPB	SOIC	D	8	2500	330.0	12.4	6.5	5.4	2.0	8.0	12.0	Q1
LMH6702MF/NOPB	SOT-23	DBV	5	1000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LMH6702MFX/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

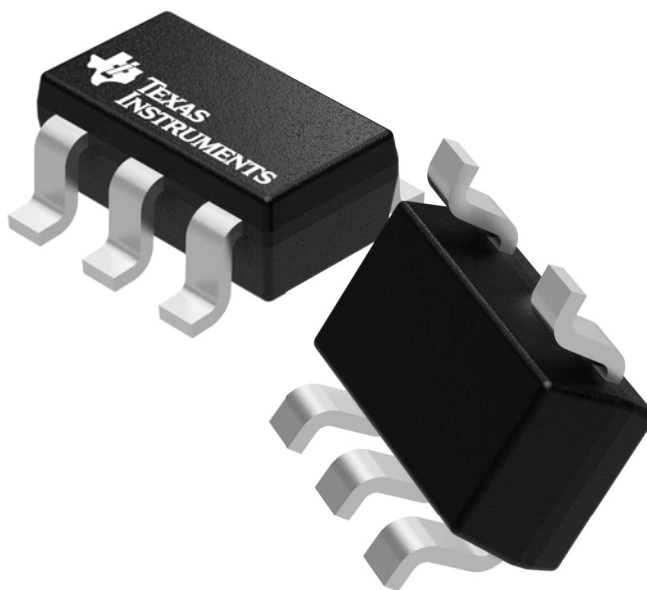
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LMH6702MAX/NOPB	SOIC	D	8	2500	367.0	367.0	35.0
LMH6702MF/NOPB	SOT-23	DBV	5	1000	210.0	185.0	35.0
LMH6702MFX/NOPB	SOT-23	DBV	5	3000	210.0	185.0	35.0

GENERIC PACKAGE VIEW

DBV 5

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

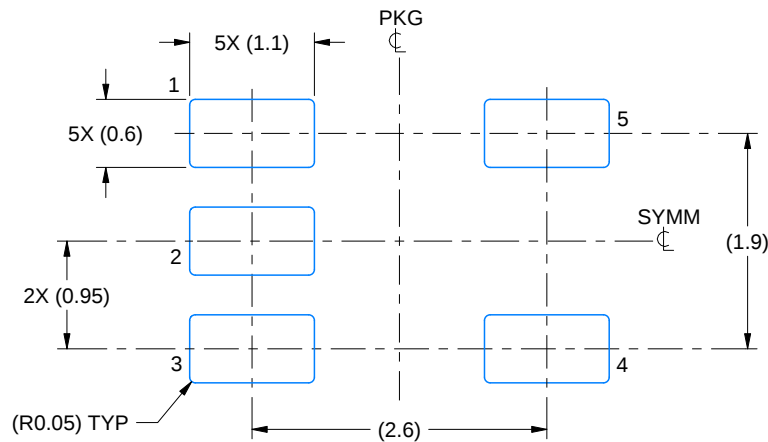
4073253/P

EXAMPLE BOARD LAYOUT

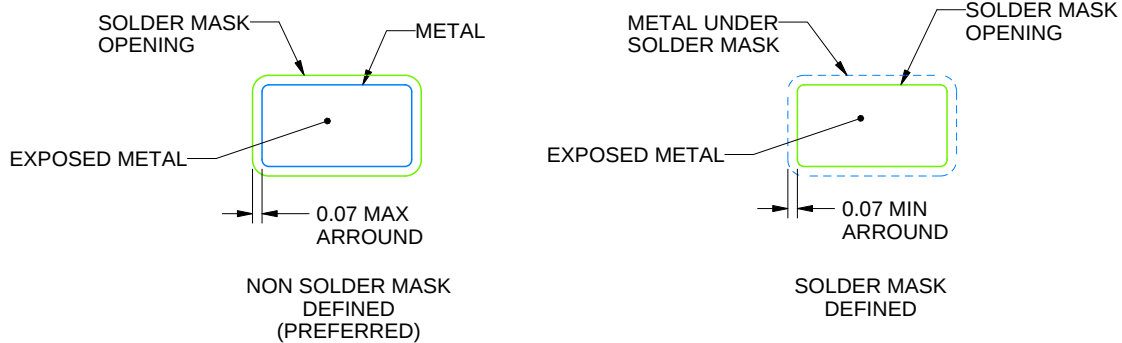
DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:15X



SOLDER MASK DETAILS

4214839/C 04/2017

NOTES: (continued)

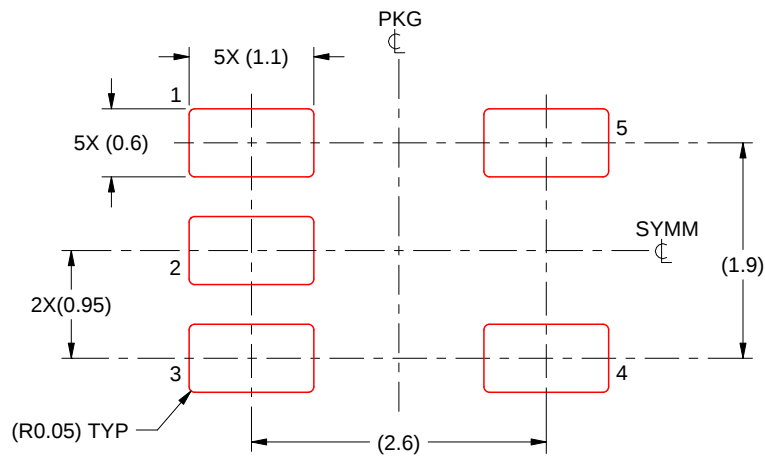
4. Publication IPC-7351 may have alternate designs.
5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:15X

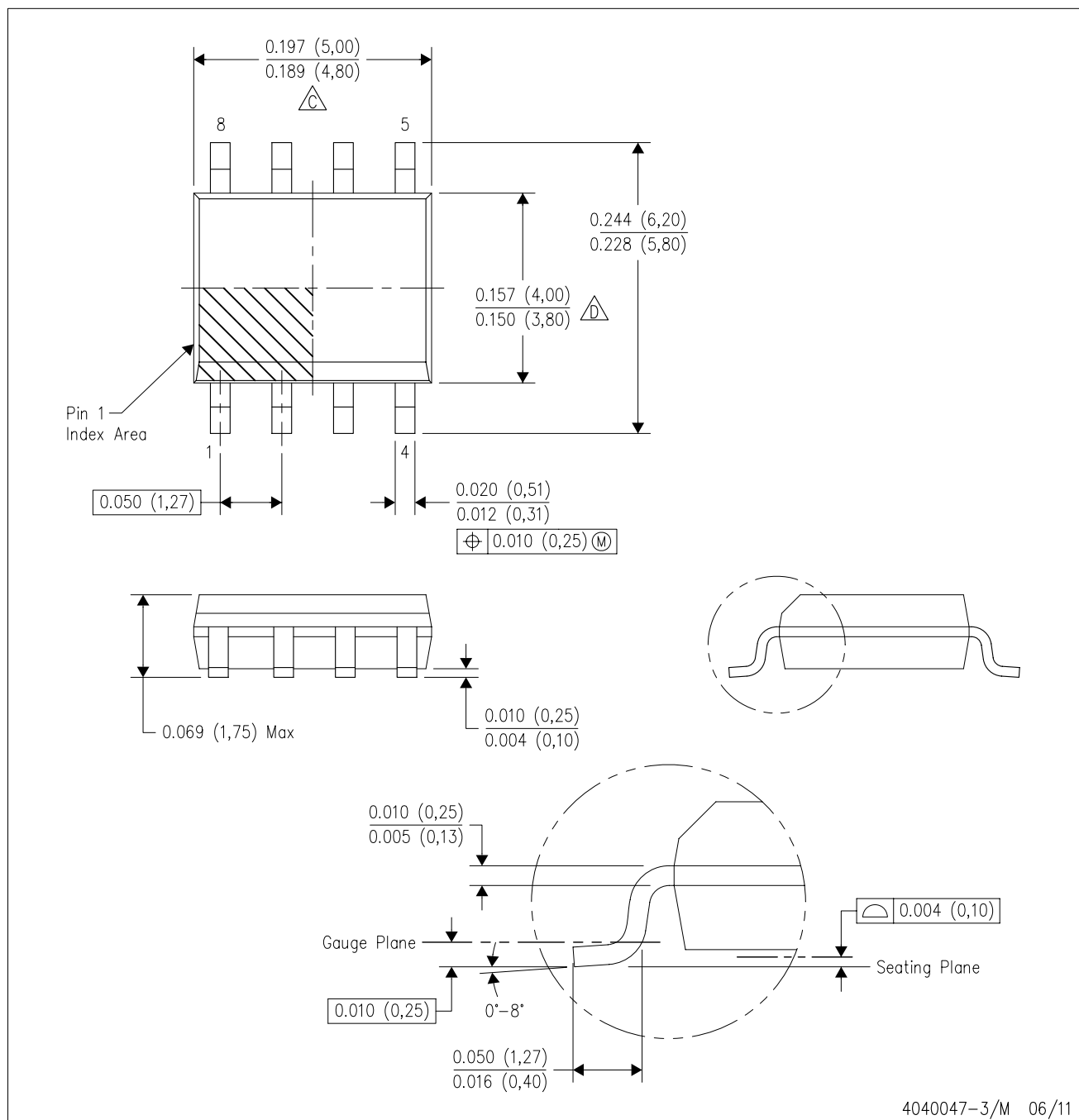
4214839/C 04/2017

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
7. Board assembly site may have different recommendations for stencil design.

D (R-PDSO-G8)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - $\triangle C$ Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
 - $\triangle D$ Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
 - E. Reference JEDEC MS-012 variation AA.

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